

Search Notes

Application/Control No.

10/606,900

Examiner

G. Nagesh Rao

Applicant(s)/Patent under
Reexamination

HAMAKAWA ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	6/7/2007	GNR
Pg Pub and Derwent Search	6/7/2007	GNR
Text Ssearch(crystallizing, semiconductor, spherical, particles, etc...)	6/7/2007	GNR
Reviewed Parent App 09/988,998	6/7/2007	GNR